## **EAST Search History**

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	5612	(die or dice or chip or chips or device or IC or element or component or devices) near8 (test\$4 near3 pad\$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/08/07 15:19
L2	1504	L1 same (wire or wiring or conductor or path)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/07 15:19
L3	985	L2 and (probe or probing or probed)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/07 15:19
L4	776	L3 and ((@ad<"20020122") or (@rlad<"20020122"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/07 15:41
L5	4944	((438/14) or (438/612)).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/08/07 15:22
L6	4687	((257/620) or (257/619) or (257/690) or (257/786)).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/08/07 15:22
L7	30	4 and 5	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/07 15:29
L8	26	4 and 6	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/07 15:30

## **EAST Search History**

L9	2	("20010052786"   "5554940").PN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/08/07 15:31
L10	6	("3795973"   "5008727"   "5089772"   "5187020"   "5241266"   "5307010"). PN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/08/07 15:41
L11	744	(bond near pad) near8 (path or connect\$4 or electrical\$4) near8 (test or tested or testing or dummy)	US-PGPUB; USPAT; USOCR	OR	ON	2006/08/07 15:41
L12	588	11 and ((@ad<"20020122") or (@rlad<"20020122"))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/08/07 16:01
L13	164	(257/619).CCLS.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2006/08/07 16:01